

**Notice of References Cited**

Application/Control No.

09/666,650

Applicant(s)/Patent Under  
Reexamination  
PEEVERS ET AL.

Examiner

Shawn M. Becker

Art Unit

2173

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,285,381	09-2001	Sawano et al.	345/726
	B	US-5,696,892	12-1997	Redmann et al.	345/582
	C	US-6,456,287	09-2002	Kamen et al.	345/427
	D	US-5,982,378	11-1999	Kato, Saul	345/582
	E	US-6,204,851	03-2001	Netschke et al.	345/419
	F	US-5,986,675	11-1999	Anderson et al.	345/473
	G	US-6,463,176	10-2002	Matsugu et al.	382/195
	H	US-6,400,374	06-2002	Lanier, Jaron	345/630
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Sahlin, Doug. "3D Mapping with UView 2.1", 4/1/00, 3D Gate, <a href="http://www.3dgate.com/tools/000501/0501uview.html">http://www.3dgate.com/tools/000501/0501uview.html</a>
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.